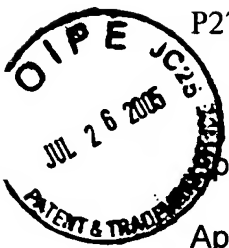


PCT # 3



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JC10 Rec'd PCT/PTO 26 JUL 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Jun KUMAGAI et al.

Appl. No : 10/532,822 (National Stage of PCT/JP2003/012319)

I.A. Filed : September 26, 2003

For : HIGH-PRESSURE DISCHARGE LAMP LIGHTING
DEVICE AND LIGHT FIXTURE EQUIPPED WITH
THE HIGH-PRESSURE DISCHARGE LAMP
LIGHTING DEVICE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop AMENDMENT
Randolph Building
401 Dulany Street
Alexandria, VA 22314
Sir:

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98, Applicants hereby bring the following information to the attention of the Examiner in charge of the above-identified application, which includes information cited in the specification and the International Search Report that issued in connection with International Patent Application No. PCT/JP2003/012319, of which the present application is the U.S. National Stage Application. A copy of the International Search Report in English was enclosed with the papers when entering the U.S. National Stage on April 26, 2005. The Examiner is requested to review these materials to inspect the relevance indicated during international examination with respect to the documents

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cited therein. The following is a list of the documents cited in the above-noted documents:

U.S. Patent No. 5,932,976 together with the Japanese family member 10-284265;

Japanese Laid-Open Utility Model Publication No. 1994/5191 (HEI 6-5191), together with an English language machine-translation of the same;

International Patent Application Publication No. WO 96/20578, together with patent family member U.S. Patent No. 5,569,984;

International Patent Application Publication No. WO 97/42650, together with patent family member U.S. Patent No. 5,923,127;

Japanese Laid-Open Patent Publication No. 2000-58284, together with an English language Abstract of the same;

International Patent Application Publication No. WO 00/78100, along with Japanese family member 2000-357617;

Japanese Laid-open Patent Publication No. 2001-297922, together with an English language Abstract of the same;

Japanese Laid-open Patent Publication No. 2002-170425, together with an English language Abstract of the same;

Japanese Laid-Open Utility Model Publication No. 1984/18460 (SHO 59-18460);

Japanese Laid-open Patent Publication No. HEI 5-198911, together with an English language Abstract of the same;

Japanese Laid-Open Utility Model Publication No. 1988/149566 (SHO 63-

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149566);

Japanese Laid-open Patent Publication No. 2002-140926, together with an English language Abstract of the same;

Japanese Laid-open Patent Publication No. HEI 9-282927, together with an English language Abstract of the same;

European Patent Application No. EP 314 077, together with a patent family member U.S. Patent No. 4,912,374;

Japanese Laid-open Patent Publication No. HEI 11-111040, together with an English language Abstract of the same. Applicants note that this document is cited on page 1 of the specification of the above-captioned application; and

Japanese Laid-open Patent Publication No. HEI 5-327161, together with an English language abstract of the same. Applicants note that this document is cited on page 3 of the specification of the above-captioned application.

Further to 37 C.F.R. §1.98 (a)(2)(ii), copies of the U.S. patents are not enclosed herewith. However, if any copies are needed, the Examiner is respectfully requested to contact the undersigned.

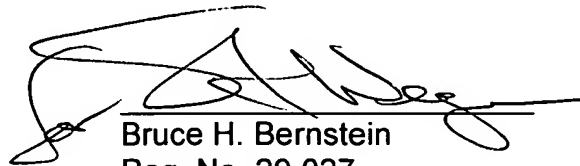
Except for the U.S. patent documents, copies of the above-noted documents are enclosed together with a duly completed Form PTO-1449. The Examiner is requested to consider each of these documents, and to make them of record in this application by initialing in the appropriate spaces on the Form PTO-1449. Applicants respectfully request that the Examiner include a copy of the initialed Form PTO-1449 with the next communication from the U.S. Patent and Trademark Office.

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Applicants note that an Office Action on the merits has not issued in the present application, and thus, no fee is believed necessary to ensure consideration of the submitted material.

Should there be any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,
Jun KUMAGAI et al.

A handwritten signature in black ink, appearing to read "Bruce H. Bernstein", is written over a horizontal line.

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Steven Wegman
Reg. No. 31,438

July 26, 2005
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FORM PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No. P27798	Application No. 10/532,822
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		Applicant Jun KUMAGAI et al.	
		I.A. Filing Date September 26, 2003	Group Not Yet Assigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLAS S	SUBCLASS	FILING DATE IF APPROPRIATE
	5 9 3 2 9 7 6	08/03/99	MAHESHWARI et al.			
	5 5 6 9 9 8 4	10/29/96	HOLTSLAG			
	5 9 2 3 1 2 7	07/13/99	KEIJSER et al.			
	4 9 1 2 3 7 4	03/27/90	NAGASE et al.			

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	0 3 1 4 0 7 7	01/26/94	E.P.O.			
11	- 1 1 1 0 4 0	04/23/99	JAPAN			
5	- 3 2 7 1 6 1	12/10/93	JAPAN			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

1	English Language Abstract of JP 2000-058284.
2	English Language Abstract of JP 2001-297922.
3	English Language Abstract of JP 2002-170425.
4	English Language Abstract of JP 5-198911.
5	English Language Abstract of JP 2002-140926.
6	English Language Abstract of JP 9-282927.
7	English Language Abstract of JP 11-111040.
8	English Language Abstract of JP 5-327161.

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.